

Hage, F.S., Hardcastle, T.P., Scott, A.J., Brydson, R. and Ramasse, Q.M. (2017) Momentum- and space-resolved high-resolution electron energy loss spectroscopy of individual single-wall carbon nanotubes. *Physical Review B*, 95(19), 195411. (doi:10.1103/PhysRevB.95.195411)

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Momentum- and space-resolved high resolution electron energy loss spectroscopy of individual single wall carbon nanotubes

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7 The ability to probe the electronic structure of individual nano-objects at high energy resolution using 8 momentum- and spatially-resolved electron energy loss spectroscopy in the scanning transmission electron 9 microscope is demonstrated through the observation of confinement of the π plasmon in individual single wall 10 carbon nanotubes. While confinement perpendicular to the tube axis was identified for all investigated tubes, a 11 variable degree of confinement parallel to the tube axis was attributed to the concentration of topological 12 defects. Spatially-resolved valence loss spectra allowed for the identification of a loss peak attributed to a 13 chirality-dependent radial interband transition. Furthermore, the importance of a careful consideration of loss 14 peak momentum dispersions for the interpretation of spatially resolved valence loss spectra is discussed.

15 **PACS number(s):** 61.48.De, 79.20.Uv, 68.37.Ma, 73.21.-b, 63.20.Pw.

17 I. INTRODUCTION

Since 1991, the interest in carbon nanotubes $(CNTs)^1$ has remained high in the scientific community. This is in 18 19 part due to the wide range of electronic properties (from semi-conducting to metallic) that single wall (SW) CNTs can exhibit². The electronic properties of a SWCNT are to a large degree determined by its chirality, 20 which is commonly described by a set of chiral indices (n, m).³ A SWCNT of a given (n, m) set of indices will 21 22 exhibit sharp non-smooth peaks in the quasi-1D valence and conduction band density of states (DoS), referred to 23 as van Hove singularities (vHSs). Scanning tunnelling spectroscopy (STS) allows for direct probing of the 24 density of states (DoS) of individual SWCNTs suspended in vacuum, however, STS measurements are reportedly afflicted by substrate effects.⁴ Transitions between the sharp vHS peaks in the valence and 25 conduction band have been reported using a range of techniques including electron energy loss spectroscopy 26 (EELS) using a purpose-built stand-alone spectrometer apparatus, ⁵⁻⁸ Rayleigh scattering spectroscopy (RSS),^{9,10} 27 fluorescence excitation spectroscopy¹¹, optical absorption spectroscopy¹² and spatial modulation (optical) 28 spectroscopy (SMS).^{13, 14} While most of these methods lack the spatial resolution to investigate individual 29 CNTs, measurements have been reported for individual suspended SWCNTs using STS⁴, RSS¹⁰ and SMS.¹³ 30

31 Due to recent advancements in transmission electron microscope (TEM) electron source monochromation,¹⁵⁻¹⁷ 32 an EEL spectrometer coupled to a TEM column now allows for detailed investigations of $\pi \rightarrow \pi^*$ transitions between the SWCNT conduction and valence vHSs.^{18, 19} Moreover, TEM and scanning (S)TEM allow for the 33 34 determination of the chiral indices of each investigated tube using either a Fourier transform (FFT) of a high resolution image^{19, 20} or an electron diffraction pattern.^{18, 21, 22} Note that the CNT valence loss spectrum (EEL< 35 50 eV) does not only contain peaks corresponding to chirality dependent $\pi \rightarrow \pi^*$ transitions but also provides 36 37 information about higher energy interband transitions involving σ states, as well as two collective modes of the 38 system: the π and $\pi+\sigma$ plasmons. The dispersion of both inter-band transitions and collective modes across the 39 Brillouin zone can be investigated by resolving valence loss spectra in momentum space. Indeed, SWCNT 40 "bulk" or ensemble measurements (i.e. averaged over samples containing a large number of SWCNTs to 41 measure) using a purpose-built stand-alone spectrometer apparatus have shown that the collective π valence electron response comprises a non-dispersive (π_1) and dispersive (π_2) mode.⁶⁻⁸ The π_1 plasmon exhibits a 42 vanishing dispersion which has been attributed to plasmon confinement perpendicular to the CNT axis,⁵⁻⁸ while 43 the distinct dispersion of the π_2 plasmon has been interpreted in terms of a plasmon propagating along the CNT 44 axis.⁶⁻⁸ This can be understood from the freedom to vary the wave vectors continuously along the unconfined 45

length of the tube which allows for modes of varying momentum, with no such freedom appearing for modes
perpendicular to the CNT axis, where allowed wave vectors are restricted to a limited number of chirality
dependent values within a discrete set (see *e.g.*²³). Momentum-resolved EELS of related carbon materials has
been reported using TEM (graphene)²⁴⁻²⁶ and STEM (individual multilayer graphene nanocones).²⁷

50 The present work is focused on taking advantage of the combined spatial and energy resolution of a state-of-the-51 art monochromated STEM-EELS system to investigate the valence loss response of individual SWCNTs in real 52 and momentum space. While momentum resolved STEM-EELS of the carbon K ionisation edge has been used to map defects in individual multiwalled CNTs,²⁸ to the knowledge of the authors, the present work is the first 53 54 report on plasmon dispersions acquired from individual SWCNTs using EELS. In contrast to methods where the spectroscopic signal is acquired from SWCNT "bulk samples",⁵⁻⁸ STEM-EELS allows uniquely for the 55 56 characterisation of the electronic structure and plasmon dispersions as a function of both the chirality of 57 individual SWCNTs and the possible presence of (atomic-sized) defects in the tubes. The present results 58 confirm that π plasmon confinement perpendicular to the CNT axis occurs for individual tubes. Moreover, an 59 observed variable π plasmon confinement parallel to the tube axis is attributed to the concentration of 60 topological defects present in the individual SWCNTs probed here. Specifically, these topological defects are 61 non-hexagonal rings incorporated in the SWCNT walls. Intriguingly, the topological-defect-induced collective 62 mode confinement appeared to predominantly affect the π valence electrons. This can be rationalised in terms of 63 non-hexagonal ring defects disrupting the delocalised π states along the tube axis, which in turn affects the 64 collective response of the π valence electrons. As σ states are significantly more localised than π states, the lack 65 of an observed confinement of the collective response of the σ valence electrons may be explained by σ states 66 being much less susceptible to isolated atomic scale defects than π states. Whilst the exact mechanism through 67 which topologically-induced π plasmon confinement occurs has yet to be determined, it is suggested that the role of topological defects in CNTs, and by extension graphene, should be taken into consideration in the 68 69 development of any novel CNT- or graphene-based plasmonic and opto-electronic devices. Moreover, it is 70 proposed that topological defect engineering could be used to form plasmonic conduits and possibly more 71 complex functional geometries in graphene. The present results highlight the advantage of combining spatially-72 and momentum-resolved valence EELS measurements. Recorded loss peak dispersions across the Brillouin zone 73 were in particular crucial in developing a coherent interpretation of $\pi+\sigma$ plasmon peak fine structure as a 74 function of distance to the nanotube axis, as well as for the assignment of a loss peak for a (13,7) metallic 75 SWCNT as a radial chirality-dependent interband transition.

76 II EXPERIMENTAL DETAILS

77 STEM-EELS experiments were carried out using a Nion UltraSTEM100MC monochromated dedicated STEM, 78 equipped with a Gatan Enfinium ERS spectrometer optimised for high-stability. The microscope was operated at 79 an acceleration voltage of 60 kV. The spatially resolved valence loss spectra in Figs. 2, 3 and 8 were acquired 80 with a convergence semi-angle (α) of 31 mrad (1.0 Å probe size) and a spectrometer collection semi-angle (β) of 81 44 mrad. C-K core loss spectra in Fig. 2 were acquired with α =31 mrad, β =60 mrad. Momentum-resolved 82 spectra shown in Figs. 5 and 6 were acquired using a "nano-diffraction mode", *i.e.* a small, mostly parallel probe with residual convergence of $\alpha = 0.9$ mrad, yielding an estimated diffraction-limited probe size of ~ 3 nm. In 83 Fig. 1, the medium angle annular dark field (MAADF) images were acquired with $\alpha = 31$ mrad, while the 84 85 diffraction patterns were acquired using the "nano-diffraction" mode ($\alpha = 0.9$ mrad).

86 The momentum selectivity of the valence loss spectra was achieved by modifying the post-specimen lens excitations as well as limiting the spectrometer acceptance angle with a rectangular spectrometer entrance slit 87 (see e.g. Refs. ^{24, 25}). The slit was oriented in such a way that the narrow part of the slit was parallel to the energy 88 89 dispersive direction of the spectrometer. This results in a two-dimensional spectrum forming on the 90 spectrometer camera, where the wave vector and EEL axes are perpendicular. This means all momentumresolved spectra were acquired in parallel, instead of serially (see e.g. Refs. 27, 29). Individual spectra were 91 extracted from the full dataset along the "wave vector axis", at an increment of the effective pixel size $\Delta q_q =$ 92 0.06 Å⁻¹. From adding the angular spread of the electron beam $2\alpha = 0.22$ Å⁻¹ and the effective slit width $\Delta q_{EEL} =$ 93 94 0.48 Å⁻¹ in quadrature, the momentum resolution was estimated to be $\Delta q \approx \pm 0.25$ Å⁻¹.

95 The energy resolution, measured as the full-width at half-maximum of the quasi-elastic zero loss peak (ZLP), 96 was 60 meV for the spatially resolved measurements and 80-120 meV for the momentum-resolved 97 measurements, at a dispersion on the spectrometer camera of 20 meV per channel where $\alpha = 31$ mrad and $\alpha =$ 98 0.9 mrad, respectively. This difference in energy resolution is attributed mostly to an increase in uncorrected 99 chromatic spectrometer aberrations accompanying the change in post specimen lens setup going from the 100 "spatially resolved" to the "momentum resolved" beam geometry. C-K ionisation edges in Fig. 2 were averaged 101 across the tube diameters and acquired with an effective energy resolution of 150 meV, at a dispersion of 50 102 meV per channel. The C-K edges were calibrated to a nominal onset of the π^* peak at 284 eV. Peak values in 103 Tables II, III and in the plots in Fig. 7 were determined by Gaussian fitting of background-subtracted spectra. The uncertainties of the measured energy loss values in Fig. 7 are primarily attributed to choice of fitting 104

105 function and fitting parameters, the magnitude of which is expected to increase with the degree of peak overlap 106 and increasing spectral noise (in practice with increasing *q*). Precisely determining these errors is problematic in 107 the present case; however an estimate was achieved by measuring peak values from the extremes of acceptable 108 fits for a select number of representative spectra over the entire measured momentum range, for all three tubes. 109 The resulting non-standard errors range from $< \pm 0.02 \text{ eV}$ at low *q* to a maximum of $\sim \pm 0.2 \text{ eV}$ for the highest 110 *q* measurements.

In Figs. 2-6, and 8, the spectral background was subtracted using a power law, except for the (13,7) tube in Figs. 5 and 6 where a 1st order polynomial model was used. The 1st order polynomial model was likely required for adequate background subtraction in order to compensate for un-resolved $\pi \rightarrow \pi^*$ contributions to the ZLP tail of the metallic tube spectra. Commercially-available powders of SWCNTs (produced through laser ablation) were dispersed onto standard lacy carbon TEM support films after sonication in ethanol. The grid was heated to 130 °C in vacuum (pressure below 5×10^{-5} Torr) prior to insertion into the microscope vacuum in order to prevent contamination build-up (extraneous hydrocarbons) which would otherwise risk covering the CNTs.

118 III RESULTS AND DISCUSSION

119 A. SWCNT chirality and defects

120 Fig. 1 shows diffraction patterns and MAADF STEM images of three tubes whose chiral indices were assigned 121 to be (15,10), (15,1) and (13,7), as discussed below. Note that the orientation of the tubes in the MAADF images 122 is not directly related to the orientations of the diffraction patterns. A SWCNT can be classified as either semiconducting or metallic based on its chiral index (n, m): a tube is metallic if 2n+m=3N (where N is an 123 integer); otherwise the tube is semiconducting.³⁰ Thus the (15,10) and (15,1) tubes are semiconducting while the 124 125 (13,7) tube is metallic. MAADF images in Fig. 1 clearly show that the tubes are single-walled, and, in the case 126 of the (15,1) tube, clean and defect free. The (15,10) and (13,7) tubes are both sparsely covered by or containing thin layers of disordered carbonaceous material, appearing as brighter contrast regions in the MAADF images 127 128 (Fig. 1). While likely primarily carbon-based, this disordered material could possibly also contain a smaller 129 amounts of other elements originating from the CNT production process. A detailed study of the carbonaceous 130 material elemental composition was however beyond the scope of the present work. Moreover, the white arrows in the images in Fig. 1 indicate the presence of topological defects in both the (15,10) and (13,7) tubes. 131 132 Specifically, Fig.1 indicates that the topological defects are primarily non-hexagonal rings (see white arrows, Fig.1) incorporated the in the graphene sheets making up the walls of the CNTs. Contributions of tubeimperfections to the recorded loss spectra will be discussed below.

Table I shows the chiral angles, ratio of chiral indices (m/n) and individual chiral indices determined from the SWCNT diffraction patterns in Fig. 1, following Refs.^{21, 22}. Ratios between the position of the first and second diffraction peak of the so-called principal layer lines in a SWCNT diffraction pattern, denoted X_2/X_1 , can be used to assign chiral indices directly.²² The precision of all values extracted from the diffraction patterns was however limited by a combination of a finite electron beam convergence and camera dynamic range. Due to these uncertainties and sources of noise, additional information was therefore used to confirm the chiral assignment.

142 The carbon K edge π^* peak fine structure is dominated by transitions from the 1s ground state to vHSs in the unoccupied DoS above the Fermi level, thus is highly sensitive to tube chirality.^{19, 31} This has been 143 demonstrated experimentally for individual SWCNTs using (S)TEM-EELS by Rossouw et al.³¹ and Senga et 144 al.¹⁹ Rossouw et al.³¹ showed that the π^* peak exhibits significantly different line shapes depending on whether 145 an individual tube is metallic and semi-conducting. Senga et al.¹⁹ investigated several individual metallic and 146 147 semi-conducting tubes, demonstrating that the π^* peak fine structure is significantly affected by tube chirality. 148 Upon detailed analysis, they found excellent agreement between experimental π^* peak fine structure and tight 149 binding calculations.¹⁹ Thus, it is clear that the C-K π^* peak fine structure can allow for detailed analysis of the 150 chirality dependent unoccupied DoS of individual SWCNTs. In the present case, Fig. 2 shows core loss spectra 151 from the (15,10), (15,1) and (13,7) tubes. The π^* fine structure in Fig. 2 clearly varies significantly with tube 152 chirality. Upon comparison to literature, the (13,7) tube π^* fine structure appears similar to that observed for metallic tubes in Refs.^{19, 31}, while the (15,1) and (15,10) tube π^* fine structures show similarities to semi-153 conducting tubes in Ref.¹⁹ and Refs.^{19, 31}, respectively. A more detailed analysis of the spectra in Fig. 2 was 154 155 beyond the scope of the present work. In a more general perspective, SWCNT C-K π^* peak fine structure analysis with a view to determine chirality directly could in some cases possibly be complicated due to factors 156 such as limited experimental spectral resolution, lifetime broadening^{19, 32} and relatively small energy separations 157 between conduction band vHSs for some tubes. Nevertheless, in comparison to valence loss spectra (discussed 158 below), the recorded C-K edge signal is highly localised,^{19, 32, 33} so that no effect from topological defects or 159 160 superimposed disordered material ≥ 1 nm away is expected to influence the EEL spectrum, which presents an 161 advantage over valence loss based assignment techniques for the analysis of local SWCNT electronic structure.

Fig. 3 shows valence loss spectra acquired from each tube with the electron beam incident on the centre of the 162 tube, indicated by the white discs in Fig. 1. Tables II and III compare $\pi \rightarrow \pi^*$ vHS peak positions for the spectra 163 in Fig. 3 to literature values obtained from Rayleigh scattering spectroscopy,^{9, 10} fluorescence excitation 164 spectroscopy,¹¹ interpolation from experimental data,⁹ optical absorption spectroscopy¹² and a prediction based 165 166 on fluorescence data.³⁴ In agreement with Sato and Terauchi¹⁸ the $\pi \rightarrow \pi^*$ vHS EELS peaks appear at up to ≈ 0.2 167 eV higher energy than those measured by optical techniques. While the EEL spectrum is proportional to the loss 168 function, the optical absorption spectrum is given by the imaginary part of the dielectric function (see e.g. Ref. ³⁵). Thus the observed vHS EELS peak values can be rationalised by the contribution of the real part of the 169 dielectric function to the loss function:^{32, 36} effectively shifting vHS EELS peaks away from the corresponding 170 171 optical values (given by maxima in the imaginary part of the dielectric function).

The nomenclature for assigning $\pi \rightarrow \pi^*$ transitions between vHSs in the valence loss spectrum follows that of refs.^{18, 19, 37} While, to the knowledge of the authors, experimental literature values confirming the energies of the (15, 10) E₅₅ - E₇₇ and (15,1) E₃₃ - E₆₆ peaks are lacking, these peaks were tentatively assigned to transitions between higher energy vHSs, as this is their most likely origin. Alternatively, assignment as "vHS peaks" might be done on the basis of theoretical modelling;¹⁸ however this was beyond the scope of the present study.

Due to the so-called trigonal warping effect²³ there is a splitting of the equivalent M_{11} and M_{22} vHS peaks 177 178 typically observed in metallic CNTs. The splitting is reflected in nomenclature where M_{11}^{+} and M_{11}^{+} (resp. M_{22}^{-} and M_{22}^{+} corresponds to the lower (-) and higher energy (+) vHSs EEL peak. The magnitude of vHS peak 179 splitting is chirality dependent.²³ Here, a clear splitting of the M₂₂ peak can be observed, whereas the splitting is 180 181 not as pronounced for the M₁₁ peak, even though for (13,7) SWCNTs, a 0.13-0.15 eV splitting of the M₁₁ peak has been reported by optical measurements.^{9, 12} The lack an obvious splitting of the M_{11} peak in the (13,7) tube 182 183 EEL spectrum in Fig. 3(a) is attributed to experimental factors: predominantly spectral noise and obfuscation by 184 the intense tail of the ZLP. Overall, by comparing experimentally-measured structural parameters and valence vHS peak energies to reported values^{9-12, 22, 34} as summarised in Tables I-III, as well as comparison of the C-K 185 core-loss fine structures to literature,^{19, 31} it was possible to unambiguously confirm the chirality assignment of 186 187 the three SWCNTs in Fig. 1.

188 B. Low loss EELS features in SWCNTs

189 In addition to "vHS" $\pi \rightarrow \pi^*$ peaks, the loss spectra in Fig. 3 exhibit further features at $\approx 4.9-5.0 \text{ eV}$, $\approx 13.7-9 \text{ eV}$ 190 and $\approx 15.6-15.8 \text{ eV}$, which are attributed to the π plasmon,^{5-7, 38} a sum over interband transitions (IB)^{6, 7} and the

 π + σ plasmon, respectively.^{5-7, 38} Plasmon peaks can be understood as arising from the incident electron beam 191 setting up a collective oscillation including only the π or all (π + σ) valence electrons.³⁹ In a first approximation 192 the "IB peak" might be attributed to a sum over $\sigma \rightarrow \sigma^*$ transitions.^{35, 40, 41} This assignment assumes that the 193 194 recorded spectrum is dominated by the $q \rightarrow 0$ tangential response. However, due to tube wall curvature and the 195 use of a finite spectrometer collection aperture, additional contributions to the IB loss peak from $\sigma \rightarrow \pi^*$ and $\pi \rightarrow \sigma^*$ transitions are expected. While diameter dependent⁴⁰ and possibly other chirality-induced effects might 196 197 be expected for EEL > 10 eV, qualitatively the IB peaks appear highly similar in all three spectra in Fig. 3. This 198 might in part be due to the more intense $\pi + \sigma$ peak obscuring any IB peak fine structure.

Due to so-called inelastic delocalisation,³² valence loss spectra record information from inelastic energy losses 199 200 occurring up to several nm away from the position of the electron probe. A varying proximity of the electron 201 beam (whose placement is indicated by the white discs in Fig. 1) to tube imperfections, such as topological 202 defects and covering disordered carbonaceous material, allows for a comparison of the contribution of these 203 imperfections to the spectra in Fig. 3. Any such effect will take the form of contributing spectral features characteristic of disordered carbon⁴² and topological defects,⁴³⁻⁴⁵ that increases in relative intensity with 204 increasing proximity to the electron beam position,³² which if present, must be taken into account in any detailed 205 206 analysis. However, when comparing the spectra of the three tubes there are no apparent < 5 eV inter-band 207 transition peaks in the (15,10) and (13,7) spectra that unambiguously could be assigned to topologically-induced electron structure modification.⁴³⁻⁴⁵ Such peaks are likely to arise due to excitations between defect states close 208 to the Fermi level,⁴³ the intensity of which should increase with increasing proximity of the electron beam to the 209 defects in question. The present results are in agreement with the results of Senga et al.¹⁹ who did not observe 210 211 any additional contribution due to tube defects in this energy range. In terms of disordered carbonaceous 212 material contribution, Fig. 4 shows there is a small increase in the shoulder of the $\pi+\sigma$ peak of the (13,7) tube 213 spectrum at $\geq \sim 20 \,\text{eV}$ as compared to the (15,1) and (15,10) tube spectra. This can be attributed to a minor contribution of the 22-23 eV π + σ plasmon of disordered carbon,⁴² rather than to any dependence on chirality or 214 215 on the presence of topological defects. Overall, the spectra in Fig. 3 therefore show no distinct features 216 characteristic of tube modification in proximity to the electron probe for energy losses < 20 eV.

217 In the recent work of Senga et al.,¹⁹ spectra acquired from metallic tubes exhibited a peak at ~ 1eV that the 218 authors attributed to the SWCNT free charge carrier plasmon, the origin of which is the collective excitation of 219 free charge carriers in metallic or doped semi-conducting SWCNTs, that propagate along the nanotube axis.

The charge carrier plasmon energy is affected by both finite CNT diameter,⁴⁶ length, and charge carrier 220 density,^{47, 48} however, the exact origin of the CNT (and graphene) charge carrier plasmon is reportedly a subject 221 of some debate in the scientific community.⁴⁸ The charge carrier plasmon, attributed to collective excitation of 222 223 the free charge carriers near the Fermi level, is thus distinctly different from the π and π + σ plasmons, which are 224 attributed to the collective excitation of the π , and, a combination of π and σ valence electrons, respectively. Intriguingly, no charge carrier plasmon peak was observed for the (13,7) tube either in the present work or for 225 the metallic tubes investigated by Sato and Terauchi.¹⁸ In the present work, distinct spectral features are clearly 226 resolved down to 0.97 and 0.79 eV for the (15,1) and (15,10) tubes in Fig. 3, respectively, indicating that the 227 228 experimental conditions would have allowed for the detection of such a feature at ~ 1eV, if present. Moreover, 229 the absence of the charge carrier plasmon peak in the present case cannot be explained solely by differences in 230 momentum resolution, which would have a determining effect on its visibility, as the spectra in Fig. 3 were acquired at a momentum resolution that is comparable to that used by Senga et al.¹⁹ The absence of an 231 observable charge carrier plasmon peak for the (13,7) tube might thus be explained either by the (13,7) charge 232 carrier plasmon peak having a much lower relative intensity than the peaks identified by Senga et al.¹⁹ (due to an 233 234 undetermined dampening mechanism specific to the specific tube observed here) or by the energy of the peak 235 appearing at an energy loss below the resolution of the experiment for the (13,7) tube. The latter seems the most 236 likely explanation: the charge carrier plasmon was reported in the literature to shift from 0.9 eV to 0.6 eV in a single defective (12,3) SWCNT, when the electron beam is moved ≈ 4 nm from a defect-free region to a region 237 238 where topological defects are present.¹⁹ In the present case the electron beam is in relatively close proximity to a section with a higher concentration of topological defects (minimum distance of 3.2 nm, see Fig. 1), which 239 might explain a possible peak value of < 0.79 eV. Moreover, Senga et al.¹⁹ suggested that unintentional doping 240 241 by the TEM support grid might explain the relatively high charge carrier plasmon peaks peak observed for the 242 metallic tubes they investigated. If in the present case the degree of a possible "unintentional doping" is 243 significantly smaller, this could also explain why the (13,7) tube charge carrier plasmon could appear at an EEL < 0.79 eV. Clearly detailed studies using monochormated STEM-EELS might significantly improve the 244 245 understanding of how the charge carrier plasmon of individual SWCNTs might be affected by tube defects and doping, as well as nanotube length^{47, 48} and diameter.⁴⁶ While a detailed study of charge carrier plasmons in 246 247 individual carbon nanotubes would likely be of significant interest to the scientific community, this is beyond 248 the scope of the present work.

250 C. Momentum resolved valence loss spectra

251 The momentum dependence of the observed SWCNT loss modes can be seen in Figs. 5 and 6, with fitted peak 252 values shown in Fig. 7. The direction of q with respect to the CNT axial direction for each tube is indicated in 253 the diffraction patterns in Fig. 1. Spectra from all three tubes show a dispersive $\pi + \sigma$ peak (*i.e.* its energy changes 254 with momentum) that broadens with increasing q and a non-dispersive IB peak that becomes indistinguishable from noise for $q \ge 0.6 - 0.7 \text{ Å}^{-1}$. As the momentum-resolved spectra were acquired in parallel, and because 255 the spectrometer camera has a finite dynamic range, the spectral intensity q^{-2} dependence³⁹ necessarily results 256 257 in spectral noise increasing significantly with increasing q. This can clearly be seen in Figs. 5 and 6. While Figs. 258 5 and 6 show smoothed spectra as a guide to the eye, the loss mode identification (Figs. 5, 6) and peak fitting 259 (Fig. 7) were carried out using the otherwise-unprocessed background-subtracted data, in order to avoid any 260 potential artefact introduced by processing.

Qualitatively the $\pi \rightarrow \pi^*$ peaks resolved in Fig. 5 appear to be non-dispersive for the (15,10) and (15,1) tubes, in agreement with the literature.^{5, 49} However, significant spectral noise made the unambiguous determination of their dispersion from the spectra in Fig. 5 problematic. For the (13,7) tube, a lack of observable $\pi \rightarrow \pi^*$ peaks for the momentum-resolved spectra is attributed to a combination of spectral noise and obscuring by the ZLP tail having increased as compared to the spectra in Fig. 3 due to a relative decrease in effective energy resolution (see section II).

The (15,10) and (15,1) tubes demonstrate arguably the most intriguing feature of these momentum-resolved spectra with a clear splitting of the π plasmon peak into a non-dispersive π_1 and a dispersive π_2 mode. While the π peak split is identifiable in Fig. 5, this is perhaps easier to observe unambiguously in Fig. 6, which shows spectra for selected momentum transfers over a limited energy loss range. The π_1 mode is present in all three tubes, but the degree to which the π_2 mode was detected varied greatly: π_2 was detected for all q for the (15,1) tube, only for $q \ge 0.72$ Å⁻¹ for the (15,10), and, not at all for the (13,7) tube.

Using a purpose-built stand-alone EEL spectrometer apparatus,⁵⁰ a π peak splitting has been identified in measurements averaged over "bulk samples" containing a large number of bundles of aligned SWCNTs.⁶⁻⁸ Kramberger et al.^{6, 7} and Liu et al.⁸ reported interpretations of the SWCNT π plasmon EEL peak splitting in terms of polarisation-dependent plasmon confinement. This suggests that the non-dispersive π_1 mode corresponds to π plasmon confinement perpendicular to SWCNT axis while the prominent dispersion of the π_2 278 mode indicates significant plasmon propagation along the SWCNT axis. While the π_1 mode was not identified by Pichler et al.⁵ and Knupfer et al.⁴⁹ they too attributed the significant dispersion of the π_2 mode to 279 280 polarisation-dependent plasmon propagation along the CNT axes. This interpretation can be illustrated 281 conceptually by considering a plasmon as the quasi-particle corresponding to envelopes over the collective 282 valence electron oscillations set up by the impinging electron beam.³² From the definition of the group velocity, 283 the dispersion of the plasmon indicates the degree to which it is allowed to propagate in the system: a non-284 dispersive plasmon indicates zero group velocity (i.e. a standing wave) and thus a localised mode, while a dispersive mode indicates a non-zero group velocity and thus significant plasmon propagation.²⁷ For detailed 285 286 analysis of SWCNT π and π + σ plasmon dispersions, local field effects (LFEs) need to be considered. Kramberger et al.⁶ showed by means of *ab initio* modelling and momentum resolved EEL spectra that LFEs are 287 288 of major importance for the π plasmon dispersion of SWCNTs (as well as for mono and bi-layer graphene). The 289 contribution of LFEs was attributed to the observed and predicted SWCNT π plasmon dispersions deviating 290 significantly from that of graphite and bundled SWCNTs.

In order to accurately interpret the observed differences in π_2 plasmon dispersion between the three tubes (Figs. 291 5-7), the experimental setup and direction momentum selectivity must first be taken into consideration. The 292 reported⁸ and inferred^{5-7, 49} π plasmon polarisation dependence means the π_1 mode will appear at the highest 293 294 relative intensity for spectra formed by collecting electrons that have imparted momentum to the sample valence 295 π electrons perpendicular to the nanotube axis. Conversely, the π_2 mode will appear at the highest relative 296 intensity for spectra formed by collecting electrons that have imparted momentum to the sample valence π 297 electrons parallel to the nanotube axis. The relative orientation of the momentum selecting slit to the tubes' axial 298 directions is indicated schematically in the diffraction patterns in Fig. 1, which gives the direction of q for each 299 measured tube (indicated in Fig. 1). This schematic demonstrates that if the π_2 mode response of all three tubes 300 was identical, experimental geometry alone would dictate that the relative intensity of the π_2 mode would 301 increase from the (15,1) tube to the (15,10) tube and be at its highest relative intensity for the (13,7) tube. 302 However, the spectra in Figs. 5 and 6 show clearly that this is not the case. Hence the results shown in Figs. 5-7 cannot be explained in terms of experimental geometry alone. 303

The observed differences in π_2 plasmon dispersion might rather be understood in terms of variable topologically-induced plasmon confinement along the nanotube axis. Specifically, it is postulated that the degree to which the π_2 mode is confined (along the tube axis) depends on the concentration of topological defects (*i.e.* 307 non-hexagonal rings) in a SWCNT. From comparing the MAADF images in Fig. 1 and the dispersions in Fig. 7, 308 it can be deduced that the π_2 mode is: significantly confined at all probed wavelengths (*i.e.* all values of q) in the 309 tube containing the largest number of topological defects (13,7); confined only at longer wavelengths $(\mathbf{q} < \approx 0.7 \text{ Å}^{-1})$ for the tube containing an intermediate number of defects (15,10); and allowed to propagate in 310 311 the range of all measured wavelengths for the least defective tube (15,1). This is consistent with a negligible 312 effect of tube defects on π_2 plasmon propagation in the (15,1) tube. A topologically-induced π_2 mode 313 confinement can be viewed as similar to the confinement of the π_1 mode perpendicular to the tube axis (induced 314 by the finite diameter of the nanotube itself). The above interpretation is in good agreement with the reported 315 identification of topologically induced π plasmon confinement at the tip of a multi-layered graphene cone.²⁷ One 316 might argue that intrinsic structural periodicity along the CNT axis might also impose collective mode 317 confinement in the system. The lattice parameters in the axial direction are (13,7): 25 Å, (15,1): 66 Å and (15,10): 19 Å, which gives first Brillouin Zone boundaries (13,7): 0.13 Å⁻¹, (15,1): 0.05 Å⁻¹ and (15,10): 0.17 Å⁻¹ 318 ¹. From comparing theses values to the dispersions in Fig. 7 it is clear that there is no obvious relationship 319 between intrinsic structural periodicity along the CNT axis and the observed degree of π_2 plasmon confinement. 320 321 Thus in the present case, π_2 mode confinement is attributed solely to the concentration of topological defects 322 incorporated in the CNT walls. Conceptually, this might be understood as non-hexagonal rings in the CNT walls 323 disrupting the delocalised π states in the tube walls, which in turn disrupts π plasmon propagation along the tube 324 axis.

325 Note that for the (15, 1) tube, the apparent difference between the π_1 and π_2 peak energies in the " $q \rightarrow 0$ 326 spectrum" (Figs. 5-7) can be explained by experimental geometry, rather than being interpreted as a result of confinement. Due to a very modest momentum resolution (\pm 0.25 Å⁻¹), all momentum resolved spectra in the 327 present work include significant contributions from a range of momentum transfers. Hence the (15, 1) tube 328 329 " $q \rightarrow 0$ spectrum" will include contributions from the dispersive π_2 mode for q up to $\approx 0.25 \text{ Å}^{-1}$. This effectively 330 blue-shifts the π_2 plasmon peak by an amount dependent on momentum resolution (*i.e.* beam convergence and 331 effective size of spectrometer collection aperture). As the π_1 mode is non-dispersive, no comparable shift is 332 expected for the π_1 peak. Thus experimental geometry in combination with differences between π_1 and π_2 mode 333 dispersions can be used to rationalise the measured energy difference between the π_1 and π_2 peaks in the " $q \rightarrow 0$ 334 spectrum" of the (15, 1) tube (Figs. 5-7).

335 In contrast, no significant differences were found between the tubes in terms of $\pi+\sigma$ or IB peak dispersions (see Figs. 5-7). Kramberger et al.^{6, 7} reported a π + σ peak split into a dispersive and non-dispersive mode for "bulk" 336 337 samples of aligned tubes. As for the π plasmon, they attributed the non-dispersive nature of the π + σ mode to 338 confinement perpendicular to the nanotube axis. While due to spectral noise, a $\pi+\sigma$ peak split could not be 339 unambiguously identified over the whole range of q values, the asymmetry of the $\pi+\sigma$ peak of the (15,10) and (15,1) spectra at high q in Fig. 5 appears very consistent with the result of Kramberger et al.^{6, 7} In light of the 340 above discussion on the π_2 mode confinement, the π + σ peak might then be expected to be show non-dispersive 341 behaviour for the (13,7) tube. Indeed, such an effect is observed for C_{60}^{51} as well as at the tip of a multilayer 342 graphene cone.²⁷ However, no localisation of the $\pi+\sigma$ mode along the tube axis is apparent for the (13,7) 343 SWCNT in Figs. 5 and 7. Thus it must be concluded that topologically-induced confinement primarily affects 344 345 the π plasmon in the SWCNTs investigated in the present work. CNT σ states are significantly more localised 346 than π states, which might explain the apparent difference in π + σ and π plasmon response to the presence of 347 non-hexagonal rings incorporated in the CNT wall, at least in part. In-depth analysis of the measured π and π + σ 348 plasmon dispersions might shed further light on the relative contributions of topological defects and chirality dependent band structure. Due to the significant contribution of LFEs in the investigated systems,⁶ such a study 349 350 would likely require comprehensive *ab into* modelling. It might also be of significant interest to investigate in 351 future work the degree to which topological defects affect the propagation of the free charge carrier plasmon 352 along the tube axis.

From the above discussion it is clear that topological defects significantly affect the plasmonic performance of SWCNTs. By extension, topological defects might thus affect the plasmonic response of graphene in a similar manner. As both CNTs and graphene are currently of significant interest for the development of plasmonic and opto-electronic devices,⁴⁶ the presence of topological defects might therefore be important to take into consideration in future developments in this field. Furthermore, it is suggested that by accurate and deliberate introduction of topological defects, the propagation of the π plasmon could be tailored in such a fashion as to form plasmonic conduits or "wires" and even more complex functional geometries.

360 D. Spatially resolved valence loss spectra

Returning to a more conventional STEM-EELS approach, the spatially-resolved valence loss spectra of (15,10),

362 (15,1) and (13,7) tubes are shown in Fig. 8 as a function of impact parameter (b). The experimental procedure is

indicated in the MAADF image of the (15, 1) tube in Fig. 1; the electron beam is moved progressively from the

364 centre of the tube (b = 0 nm) indicated by the white discs (Fig. 1.), past the tube wall (b = 0.5-1nm) and into vacuum (b > -1nm) with increasing distance to the tube centre (*i.e.* increasing b). Overall, loss peak intensities 365 decrease with increasing impact parameter for all three tubes, in agreement with the literature.^{38, 52, 53} In a 366 367 classical particle description, the maximum impact parameter allowed (in the adiabatic limit) can be expressed as $b_{max} = v_0 / (E / \hbar)$, where E is the energy loss and v_0 is the (relativistic) velocity of the impinging 368 electron.³² The possibility to excite a mode at a given E for an impact parameter up to b_{max} , is often referred to as 369 370 inelastic delocalisation. Effectively, a loss peak at a certain E will decrease more in intensity with increasing bthan a lower energy peak, 32 as is the trend for all three tube spectra in Fig. 8. 371

372 For the (13,7) tube, a \approx 5.5 eV peak on the high energy shoulder of the π plasmon peak appears to increase from the tube centre (b = 0 nm) to the tube wall (b = 0.5-1.0 nm). For b > -1 nm, qualitatively the ≈ 5.5 eV peak 373 374 decreases in intensity along with the rest of the peaks in the spectrum in agreement with inelastic scattering 375 theory, discussed above. To understand the relative increase in ≈ 5.5 eV peak intensity from b = 0 nm to b = 0376 0.5-1.0 nm, both experimental geometry and π_2 mode dispersion need to be taken into consideration. For the 377 (15,1) and (15,10) tubes the higher energy shoulder of their respective π peaks can be attributed to the π_2 mode. 378 As discussed above, due to the use of finite beam convergence and spectrometer collection angles (see section 379 II), higher q components of the π_2 mode contribute to the recorded spectrum, resulting in an apparent blue-shift of the π_2 mode, with respect to the " π peak". As the π_2 mode can be attributed to the tangential tube response,³⁸ 380 381 the observed gradual decrease of the (15,1) and (15,10) " π_2 shoulder" intensities with increasing **b** is as expected 382 from inelastic scattering theory.

383 However, as no dispersive π_2 mode was observed for the (13,7) tube (see Figs. 5-7), the presence of the \approx 5.5 eV 384 peak must be understood in terms of experimental geometry. Due to a finite beam convergence and spectrometer 385 collection aperture (see section II) the EEL spectrum is dominated by electrons having undergone momentum 386 transfer perpendicular to the incident beam direction. Thus when the electron beam is incident on the nanotube 387 axis (b = 0 nm) the spectrum is dominated by the CNT tangential response. However, when the beam is moved 388 to the wall of the nanotube (b = 0.5-1.0nm), the relative radial contribution increases significantly. As the ≈ 5.5 389 eV peak increases significantly in intensity from b = 0 nm to b = 0.5-1.0 nm for the (13,7) tube, the peak is 390 tentatively attributed to a chirality dependent interband transition associated with the radial response of the 391 (13,7) SWCNT. Being attributed to the radial rather than the tangential response, clearly differentiates the (13,7) 392 \approx 5.5 eV peak from the " π_2 mode shoulders" of the (15,1) and (15,10) tubes in Fig. 8. A more accurate mode

assignment of the $(13,7) \approx 5.5$ eV peak might result from theoretical modelling, possibly requiring the inclusion of depolarisation and excitonic effects. This is however beyond the scope of the present work.

395 In light of the above discussion, a significant reduction in the high energy shoulder of the $\pi+\sigma$ peak with 396 increasing b for all three tubes might also be understood in terms of experimental geometry and loss mode 397 dispersion. For b = 0 nm the $\pi + \sigma$ peak results from the spectrometer accepting electrons that have undergone a 398 range of momentum transfers, beyond the first Brillouin zone. As the $\pi+\sigma$ mode is dispersive (see Fig. 8), it 399 follows that the corresponding loss peak is effectively broadened on the high energy loss side by the higher q400 contributions of the $\pi+\sigma$ response. With increasing b the relative magnitude of q of the tangential tube response contributing to the collected spectrum decreases. As the SWCNTs $\pi+\sigma$ mode is tangential,³⁸ the contribution of 401 402 the high q components of the $\pi+\sigma$ mode to the recorded loss peak decreases with increasing b. Thus, the 403 broadening of the π + σ peak is reduced with increasing **b** for SWCNTs. This result clearly shows that a coherent 404 interpretation of the spatially resolved spectra results in Fig. 8 not only requires knowledge of sample 405 orientation and experimental parameters but also of the momentum dependence of the SWCNT loss modes 406 themselves. In extension, similar considerations might prove useful when using valence EELS to studying other 407 low-dimensional and anisotropic samples.

408

409 IV. CONCLUSION

410 STEM-EELS allows for a flexible and comprehensive characterisation of the electronic structure of individual 411 SWCNTs. Information that can be obtained includes: chiral indices and structure, identification of topological 412 defects and disordered carbonaceous material coverage (and their effect on EEL spectra), chirality-dependent 413 interband transition energies and C-K ionisation edge fine structure, and, determination of plasmon and 414 interband transition peak dispersions. The energy resolution provided by state-of-the-art STEM 415 monochromators allows for spectral analysis of electronic structure comparable to that of many optical methods 416 and dedicated EEL spectrometers. But crucially, STEM-EELS allows for the investigation of individual tubes 417 and their defects, which is information that to a large degree is obscured in results from many optical 418 spectroscopic methods and dedicated EEL spectrometers. In order to achieve the spatial resolution necessary to 419 identify individual SWCNTs, the momentum resolution in the present work is significantly poorer than that 420 offered by stand-alone dedicated spectrometers. However, due to the highly flexible optics of the electron 421 microscope the intrinsic trade-off between spatial and momentum resolution can be optimised for a given

422 experiment. Thus the momentum resolution could be made to approach that of dedicated spectrometers, if423 required.

424 The present results highlight the advantages of combining information from spatially- and momentum-resolved 425 measurements when evaluating the effects of nanotube defects and chirality. Moreover, a careful comparison of 426 spatially- and momentum-resolved spectra from the same nano-object emphasises how the relative sample 427 orientation and choice of experimental parameters along with the dispersions of relevant loss modes might 428 significantly affect valence EEL spectra of SWCNTs. The degree of π plasmon confinement parallel to the 429 SWCNT axis was shown to be dependent on the local concentration of topological defects. While the exact 430 mechanism for confinement remains unclear, this suggests that the plasmonic response of SWCNTs could be 431 tailored by accurate control of the topological defect concentration. By extension, a similar degree of tailoring 432 might be possible for graphene with the aim to create plasmonic conduits or "wires" and even more complex 433 functional geometries. Thus accurate control of the plasmonic response through the use of topological defects 434 might prove to be beneficial in the development of SWCNTs or graphene based novel plasmonic and opto-435 electrionic devices.

436 ACKNOWLEDGEMENTS

The authors gratefully acknowledge O Krivanek, N Dellby and TC Lovejoy (Nion Company, WA, USA) for
useful discussions and advice in setting up the momentum resolved measurements, and U Bangert (University of
Limerick, Ireland) for providing CNT samples. SuperSTEM is the UK Engineering and Physical Sciences
Research Council (EPSRC) National Facility for Aberration Corrected STEM. T. P. Hardcastle gratefully
acknowledges the EPSRC Doctoral Prize Fellowship which funded this research.

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535 FIG. 1. MAADF images and diffraction patterns of three SWCNTs. Topological defects in the (15,10) and 536 (13,7) tubes are indicated by white arrows. The momentum-selecting slit orientations and the tube axis 537 directions are indicated in the diffraction patterns. The orientation of the tubes in the MAADF images is not 538 directly related to the orientations of the diffraction patterns. The white discs superimposed on the MAADF 539 images indicate the beam potions at which the spectra in Fig. 3 were acquired. The white lines superimposed on 540 the MAADF images indicate the distance between the beam positions (white discs) and tube defects. The dashed 541 white arrow in the (15,1) tube MAADF image illustrates the experimental setup used to acquire the spectra 542 shown in Fig. 8.



544 FIG. 2. Core loss C-*K* edges from the SWCNTs.



547 FIG. 3. Valence loss spectra from the three tubes.





549

550 FIG. 4. Comparison of the π + σ plasmon peaks from the three tubes. The black arrow indicates the spectral 551 contribution of disordered carbonaceous material deposited on or inside the (13,7) tube.

553

554 TABLE I. Experimental SWCNT structural parameters determined from the diffraction patterns in Fig. 1 (exp.)

555 compared to the predicted values.²²

Nanotube	Chiral angle (°)	m/n	X ₂ /X ₁	$m (X_2/X_1)^{22}$
(15,10) exp. (Ref. ²²)	24 (23.413)	0.7 (0.667)	1.41	10 (1.398) or 9 (1.428)
(15,1) exp. (Ref. ²²)	2 (3.192)	0.04 (0.0667)	2.89	1 (2.892)
(13,7) exp. (Ref. ²²)	21 (20.174)	0.6 (0.5385)	1.48	7 (1.507) or 8 (1.465)

557

558 TABLE II. Measured $\pi \rightarrow \pi^*$ "vHs peak" values for the (15,10) and (15,1) tubes, compared to reported values 559 from Rayleigh scattering spectroscopy,^{9, 10} fluorescence excitation spectroscopy,¹¹ optical absorption 560 spectroscopy¹² and empirical prediction based on florescence data.³⁴

Semiconducting	E ₁₁ (eV)	E ₂₂ (eV)	E ₃₃ (eV)	E ₄₄ (eV)
(15 10) EELS	0.79	1 22	2 11	2 47
(15,10) EELS	0.73	1.22 1.072 (Ref. ³⁴)	2.11 2.13 2.15 (Refs. 9,10)	2.47 $2.41 + 2.44 (\text{Refs}^{9,10})$
(15,10) (15,1) EELS	0.024 (Ref.)	1.072 (Ref.)	2.15, 2.15 (Refs.)	2.41, 2.44 (Refs.)
(15,1) EELS (15,1) (Defending 11, 12, 34)	0.97	1.40	2.70	5.19
(15,1) (Reis.)	0.870, 0.848,	1.337, 1.379,	n/a	n/a
(,-) ()	0.869	1.347		

562

563 TABLE III. Measured $\pi \rightarrow \pi^*$ "vHs peak" values for the (13,7) tube, compared to values interpolated from

564 experimental optical data ⁹ and optical absorption spectroscopy.¹²

Metallic	$M_{11}^{\pm}(eV)$	$M_{22}^{\pm}(eV)$
(13,7) EELS	2.15	3.30 (-) 3.61 (+)
(13,7) (Refs. ^{9, 12})	1.81 (-) 1.96 (+), 1.857(-) 1.984 (+)	n/a



FIG. 5. ZLP-subtracted momentum-resolved valence loss spectra of the SWCNTs. Smoothed data (red) super imposed on the raw data (grey) as a guide to the eye. Spectral intensities are scaled for ease of comparison. The direction of q with respect to the CNT axial direction for each tube is indicated in the diffraction patterns in Fig. 1.



FIG. 6. Selected momentum-resolved valence loss spectra of the SWCNTs. Smoothed data (red) superimposed
on the raw data (grey) as a guide to the eye. Spectral intensities are scaled for ease of comparison. The direction
of *q* with respect to the CNT axial direction for each tube is indicated in the diffraction patterns in Fig. 1.



577

578 FIG. 7. SWCNT valence loss peak dispersions. Errors in energy loss peak positions are estimated to range from 579 $< \pm 0.02$ eV at low q to a maximum of $\sim \pm 0.2$ eV for the highest q measurements. The momentum 580 resolution is estimated to $\Delta q \approx \pm 0.25$ Å⁻¹. The direction of q with respect to the CNT axial direction for each 581 tube is indicated in the diffraction patterns in Fig. 1.



FIG. 8. Spatially-resolved valence loss spectra as a function of impact parameter. The black arrow indicates achirality-dependent radial interband transition.